

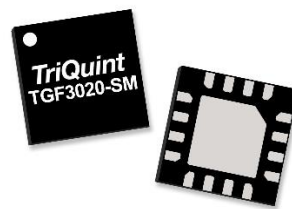
### Product Overview

The Qorvo TGF3020-SM is a 5W ( $P_{3dB}$ ), 50  $\Omega$  -input matched discrete GaN on SiC HEMT which operates from 4.0 to 6.0GHz. The integrated input matching network enables wideband gain and power performance, while the output can be matched on board to optimize power and efficiency for any region within the band.

The device is housed in an industry-standard 3 x 3 mm surface mount QFN package.

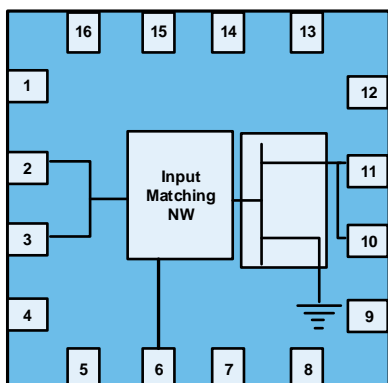
Lead-free and ROHS compliant

Evaluation boards are available upon request.



3 x 3mm QFN package

### Functional Block Diagram



### Key Features

- Frequency: 4 to 6 GHz
  - Output Power ( $P_{3dB}$ )<sup>1</sup>: 6.8 W
  - Linear Gain<sup>1</sup>: 13 dB
  - Typical PAE<sub>3dB</sub><sup>1</sup>: 60%
  - Operating Voltage: 32 V
  - CW and Pulse capable
- Note 1: @ 5 GHz Load Pull

### Applications

- Telemetry
- C-band radar
- Communications
- Test instrumentation
- Wideband amplifiers
- 5.8GHz ISM

### Ordering Information

Part No.	Description
TGF3020-SM	QFN Packaged Part
TGF3020-SMEVB01	5.3 – 5.9 GHz EVB
TGF3020-SMEVB02	4 – 6 GHz EVB

### Absolute Maximum Ratings<sup>1</sup>

Parameter	Rating	Units
Breakdown Voltage, $BV_{DG}$	+100	V
Gate Voltage Range, $V_G$	-7 to +2	V
Drain Current, $I_{D_{MAX}}$	0.6	A
Power Dissipation, $P_{DISS}^2$	10.4	W
RF Input Power, CW, $T = 25^\circ\text{C}$	+30	dBm
Storage Temperature	-65 to +150	$^\circ\text{C}$

Notes:

1. Operation of this device outside the parameter ranges given above may cause permanent damage.
2. Pulsed 100uS PW, 20% DC

### Recommended Operating Conditions<sup>1</sup>

Parameter	Min	Typ	Max	Units
Operating Temp. Range	-40	+25	+85	$^\circ\text{C}$
Drain Voltage Range, $V_D$	+12	+32	+40	V
Drain Bias Current, $I_{DQ}$		25		mA
Drain Current, $I_D^4$	–	0.25	–	A
Gate Voltage, $V_G^3$	–	-2.8	–	V
Power Dissipation ( $P_D$ ) <sup>2,4</sup>	–	–	7.6	W
Power Dissipation ( $P_D$ ), CW <sup>2</sup>	–	–	6.2	W

Notes:

1. Electrical performance is measured under conditions noted in the electrical specifications table. Specifications are not guaranteed over all recommended operating conditions.
2. Package base at  $85^\circ\text{C}$
3. To be adjusted to desired  $I_{DQ}$
4. Pulsed, 100uS PW, 20% DC

### Measured Load Pull Performance – Power Tuned<sup>1, 2</sup>

Parameter	Typical Values				Units
Frequency, F	4	4.4	5	5.5	GHz
Drain Voltage, $V_D$	32	32	32	32	V
Drain Bias Current, $I_{DQ}$	25	25	25	25	mA
Output Power at 3dB compression, $P_{3dB}$	38.4	38.3	38.3	38.2	dBm
Power Added Efficiency at 3dB compression, $PAE_{3dB}$	50.1	50.4	49.5	53.0	%
Gain at 3dB compression, $G_{3dB}$	9.6	9.7	9.7	10.3	dB

Notes:

1. Pulsed, 100 uS Pulse Width, 20% Duty Cycle
2. Load-pull characteristic Impedance,  $Z_o = 50 \Omega$ .

### Measured Load Pull Performance – Efficiency Tuned<sup>1, 2</sup>

Parameter	Typical Values				Units
Frequency, F	2.7	2.9	3.1	3.3	GHz
Drain Voltage, $V_D$	32	32	32	32	V
Drain Bias Current, $I_{DQ}$	25	25	25	25	mA
Output Power at 3dB compression, $P_{3dB}$	37.6	36.8	37.1	36.8	dBm
Power Added Efficiency at 3dB compression, $PAE_{3dB}$	60.1	61.5	59.6	59	%
Gain at 3dB compression, $G_{3dB}$	10.3	10.3	10.1	10.7	dB

Notes:

1. Pulsed, 100 uS Pulse Width, 20% Duty Cycle
2. Load-pull characteristic Impedance,  $Z_o = 50 \Omega$ .

### RF Characterization 5.3 – 5.9 GHz EVB – 5.4 GHz Performance<sup>1</sup>

Parameter	Min	Typ	Max	Units
Linear Gain, $G_{LIN}$	–	11.7	–	dB
Output Power at 3dB compression point, P3dB	–	5.7	–	W
Drain Efficiency at 3dB compression point, DEFF3dB	–	53.1	–	%
Gain at 3dB compression point, G3dB	–	8.7	–	dB

Notes:

1.  $V_D = +32\text{ V}$ ,  $I_{DQ} = 25\text{ mA}$ , Temp = +25 °C, Pulse Width = 100 uS, Duty Cycle = 20%

### RF Characterization 4 – 6.0 GHz EVB – 4.7 GHz Performance<sup>1</sup>

Parameter	Min	Typ	Max	Units
Linear Gain, $G_{LIN}$	–	11.8	–	dB
Output Power at 3dB compression point, P3dB	–	5.6	–	W
Drain Efficiency at 3dB compression point, DEFF3dB	–	51.7	–	%
Gain at 3dB compression point, G3dB	–	8.8	–	dB

Notes:

1.  $V_D = +32\text{ V}$ ,  $I_{DQ} = 25\text{ mA}$ , Temp = +25 °C, Pulse Width = 100 uS, Duty Cycle = 20%

### RF Characterization – Mismatch Ruggedness at 5.3 and 5.9 GHz

Symbol	Parameter	dB Compression	Typical
VSWR	Impedance Mismatch Ruggedness	3	10:1

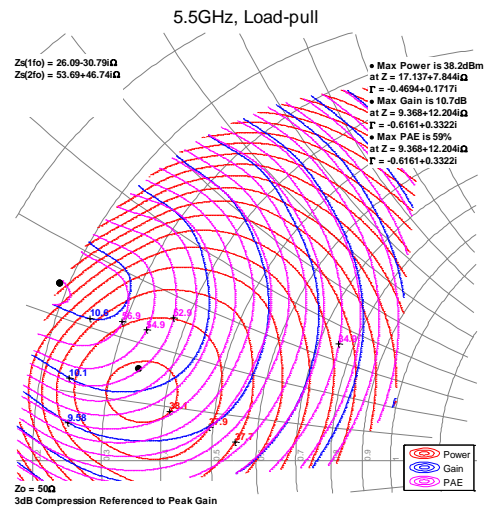
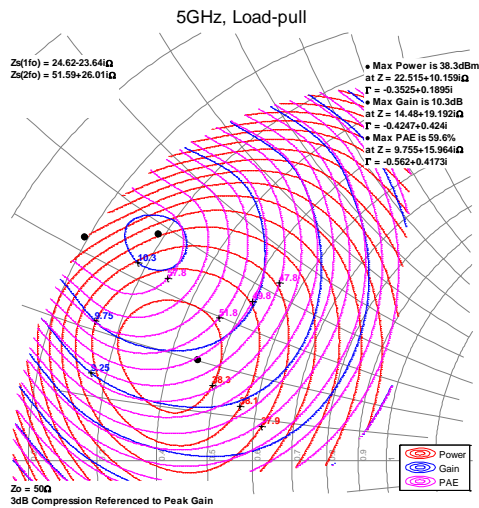
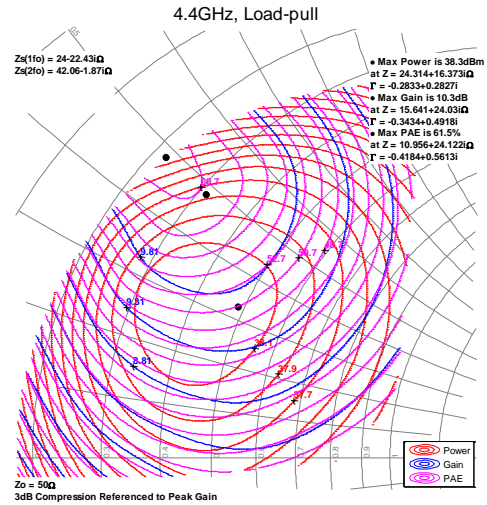
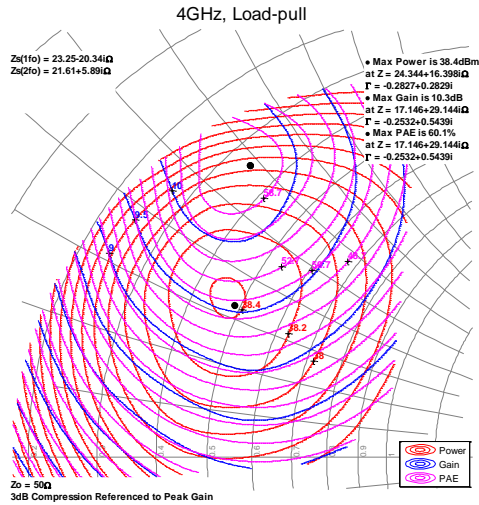
Test conditions unless otherwise noted:  $T_A = 25\text{ °C}$ ,  $V_D = 32\text{ V}$ ,  $I_{DQ} = 25\text{ mA}$

Input drive power is determined at pulsed 3dB compression under matched condition at EVB output connector.

### Measured Load-Pull Smith Charts<sup>1, 2</sup>

#### Notes:

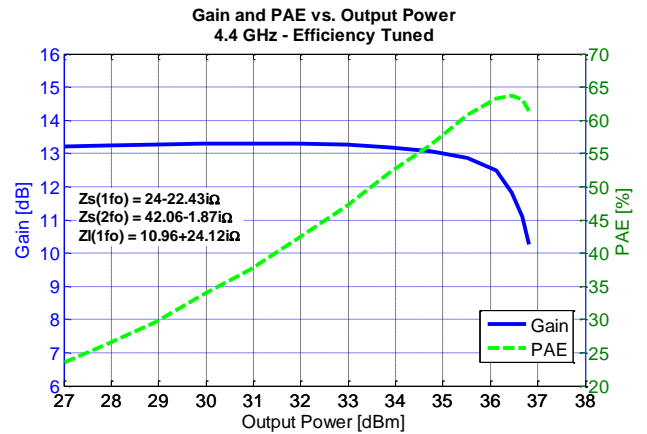
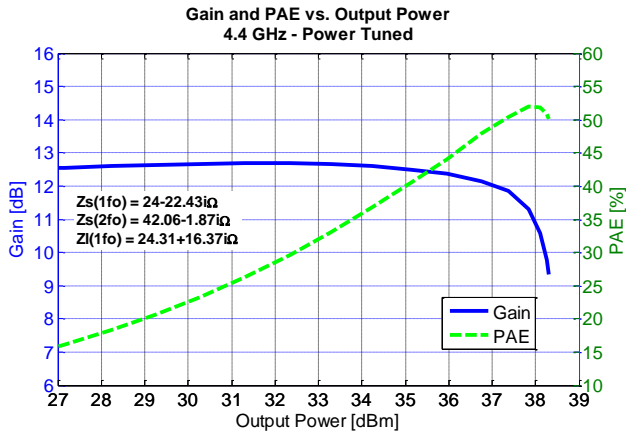
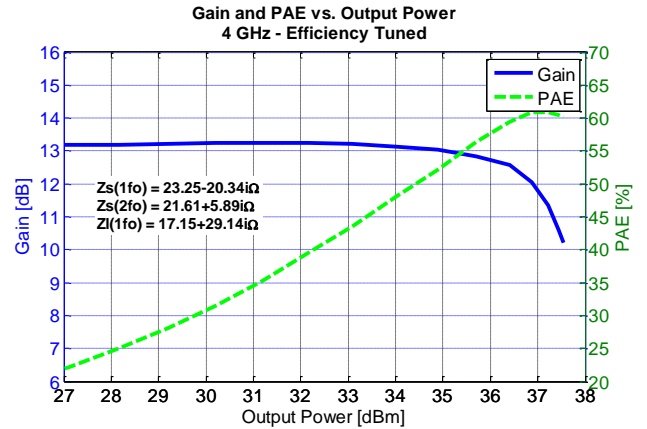
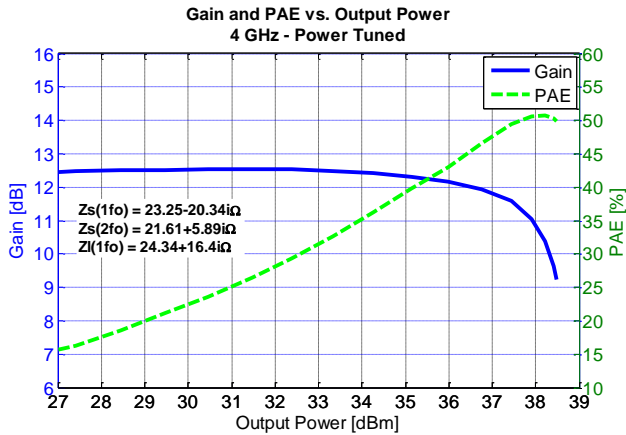
1. Test Conditions:  $V_D = 32$  V,  $I_{DQ} = 25$  mA, 100  $\mu$ S Pulse Width, 20% Duty Cycle



### Typical Measured Performance – Load-Pull Drive-up<sup>1, 2</sup>

Notes:

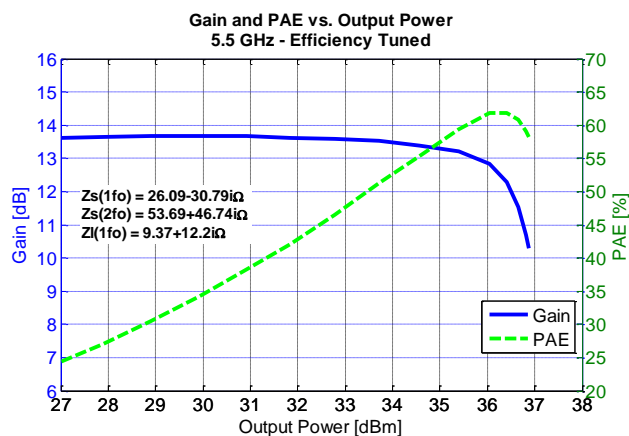
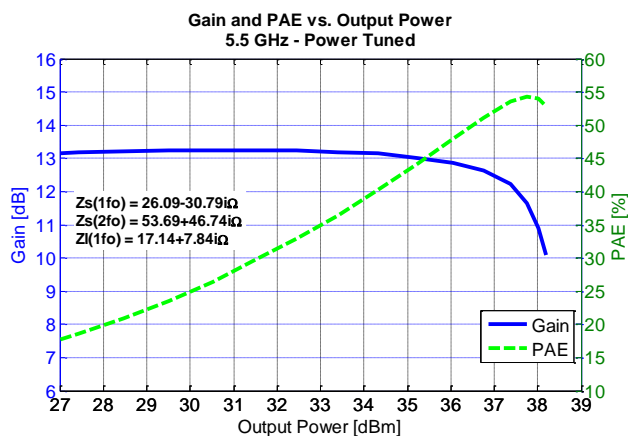
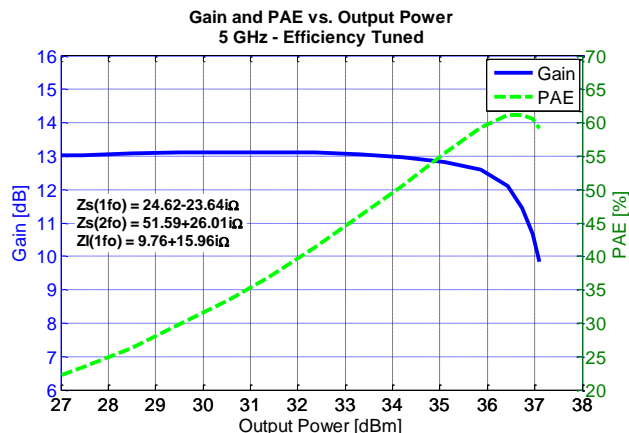
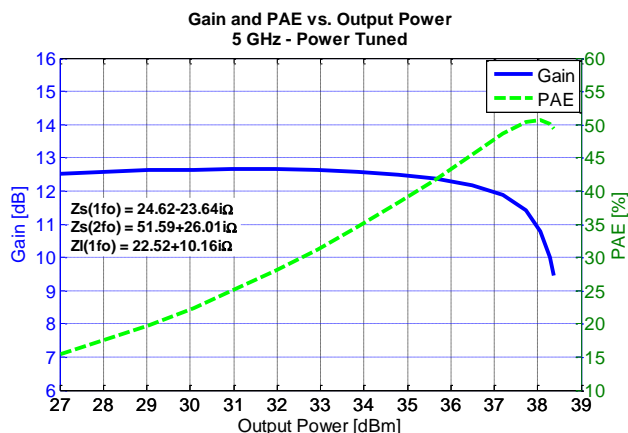
1. Pulsed signal with 100uS pulse width and 20% duty cycle



## Typical Measured Performance – Load-Pull Drive-up<sup>1, 2</sup>

Notes:

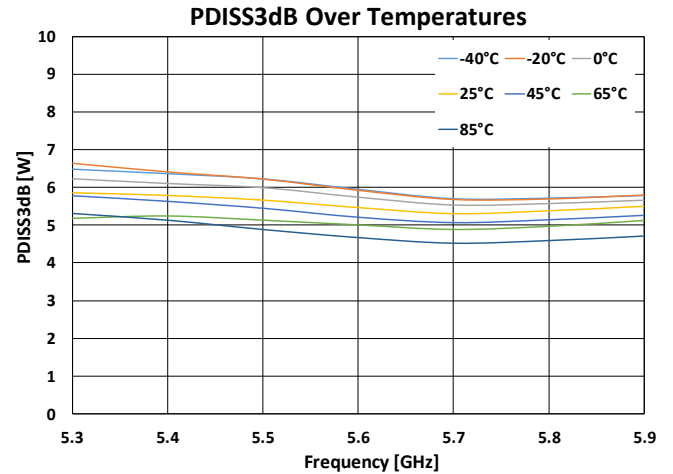
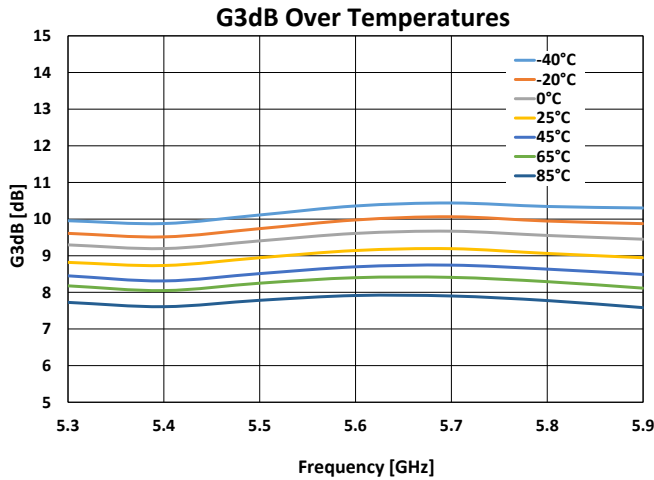
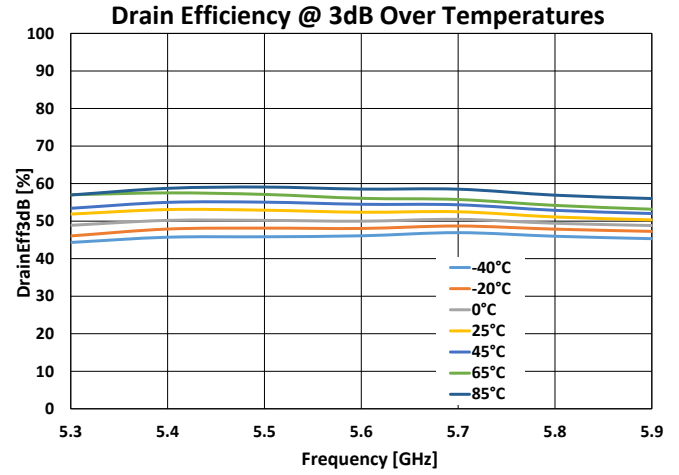
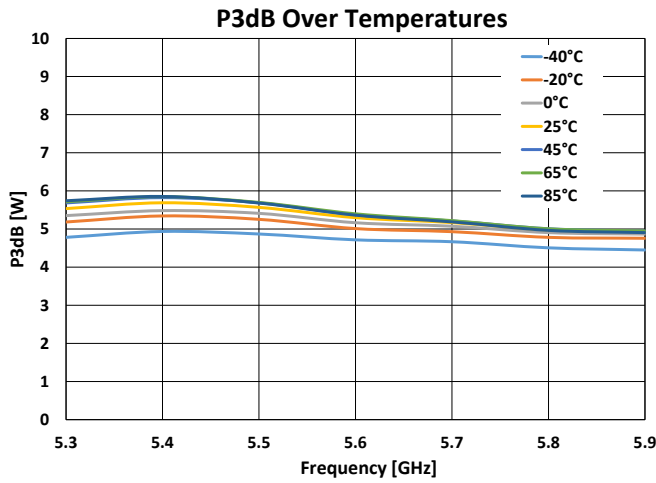
1. Pulsed signal with 100uS pulse width and 20% duty cycle



### Power Driveup Performance Over Temperatures Of 5.3 – 5.9 GHz EVB<sup>1,2</sup>

Notes:

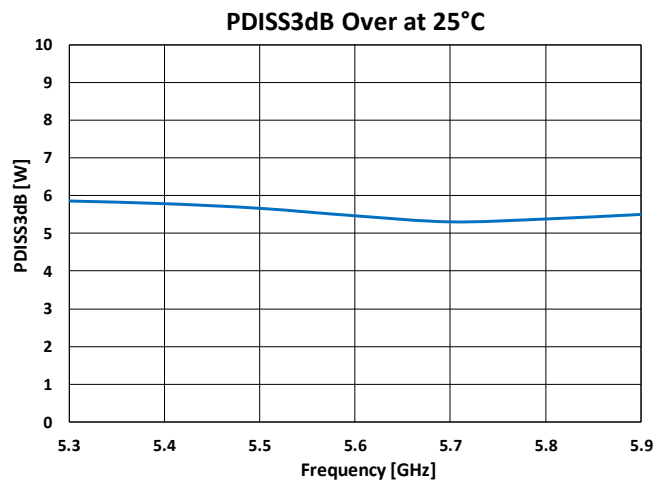
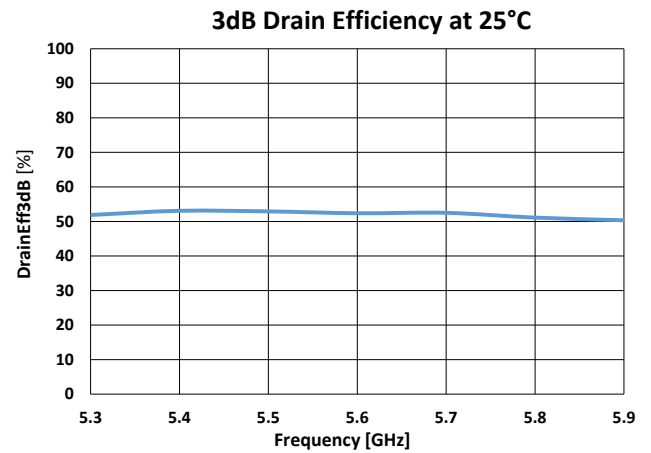
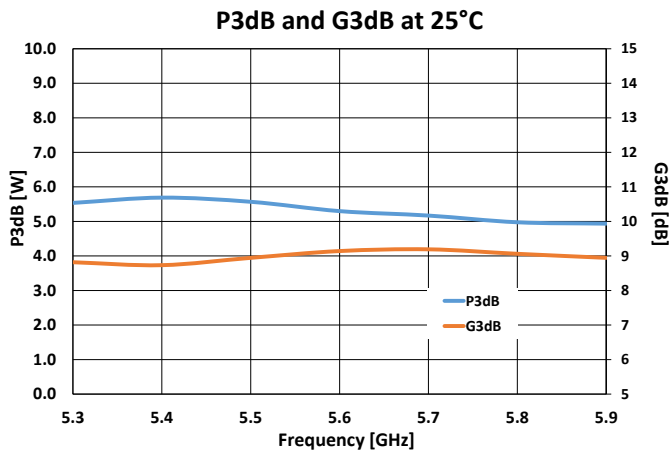
1. Test Conditions:  $V_D = 32$  V,  $I_{DQ} = 25$  mA, 20  $\mu$ S Pulse Width, 20% Duty Cycle
2. The dissipation power limit is conservative because it is specified at DUT only without accounting for the loss of the output matching network.



### Power Driveup Performance At 25°C Of 5.3 – 5.9 GHz EVB<sup>1, 2</sup>

Notes:

1. Test Conditions:  $V_D = 32$  V,  $I_{DQ} = 25$  mA, 20  $\mu$ S Pulse Width, 20% Duty Cycle
2. The dissipation power limit is conservative because it is specified at DUT only without accounting for the loss of the output matching network..

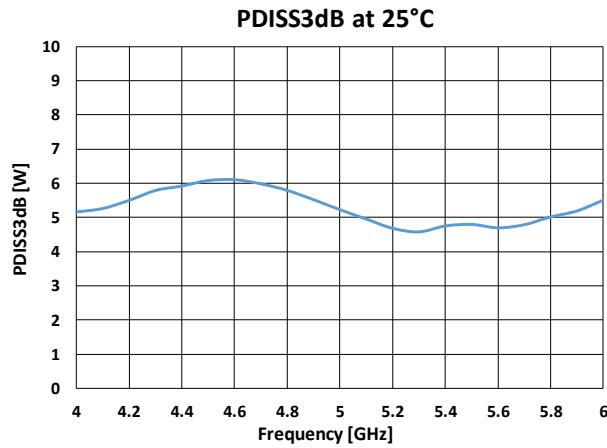
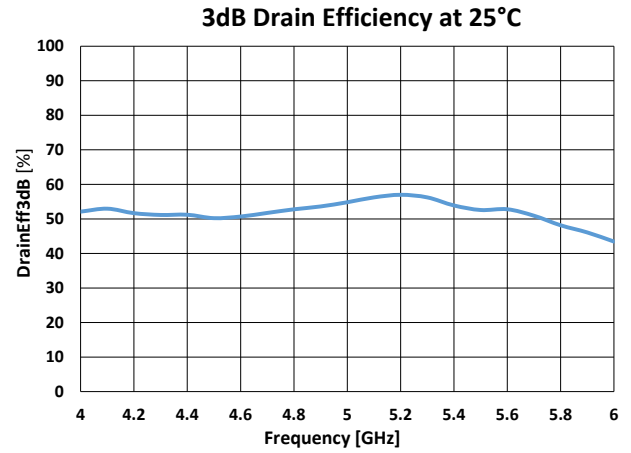
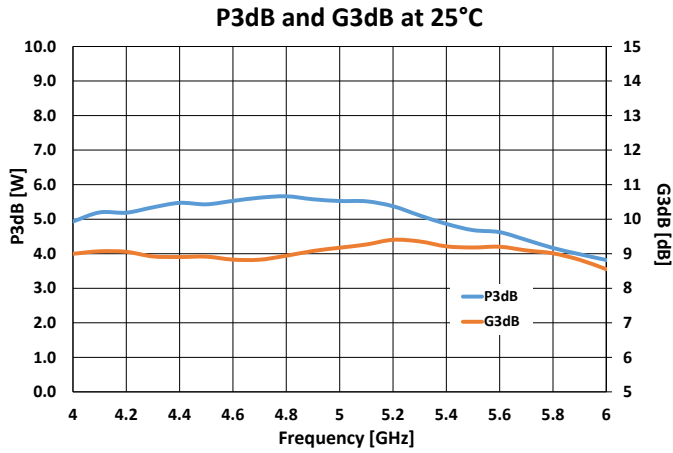




### Power Driveup Performance At 25°C Of 4 – 6 GHz EVB<sup>1, 2</sup>

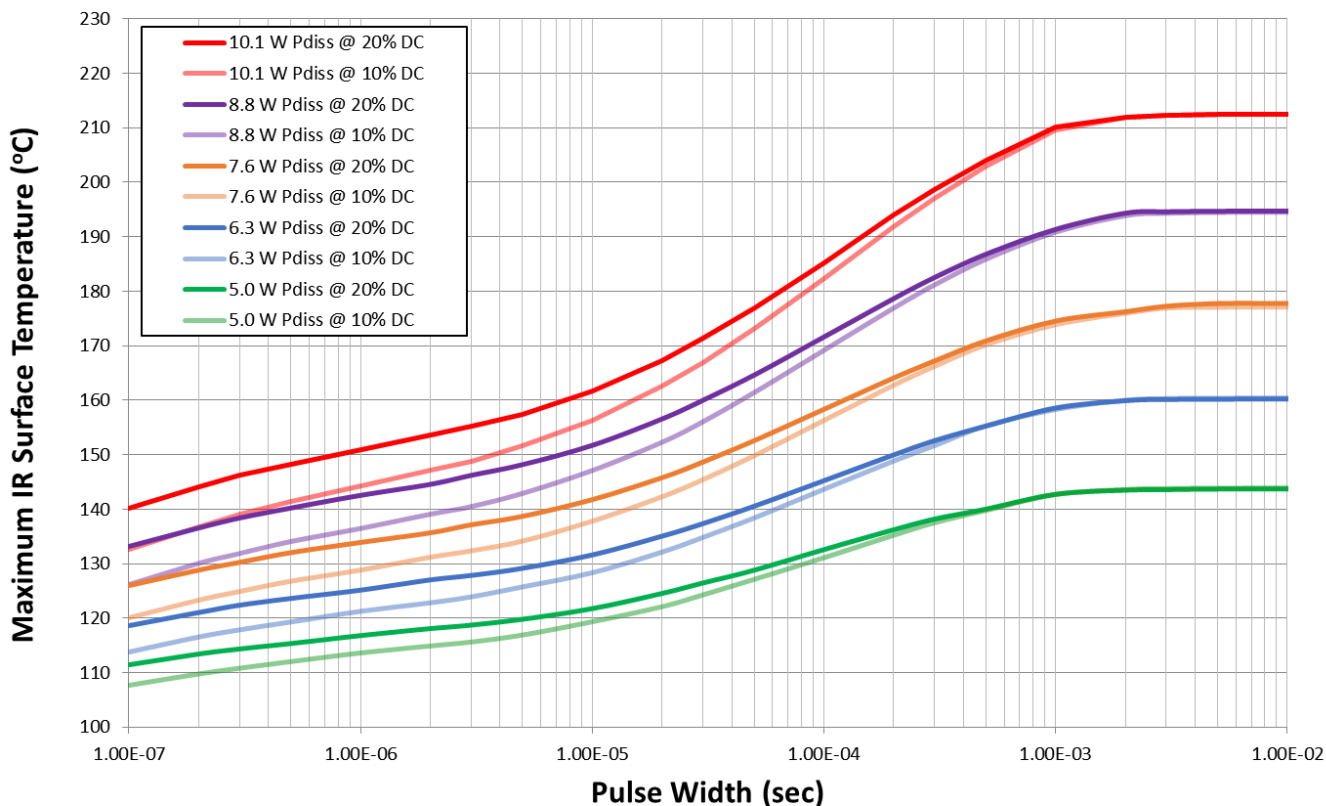
Notes:

1. Test Conditions:  $V_D = 32$  V,  $I_{DQ} = 25$  mA, 100 uS Pulse Width, 20% Duty Cycle
2. The dissipation power limit is conservative because it is specified at DUT only without accounting for the loss of the output matching network..



### Thermal and Reliability Information – Pulsed<sup>1</sup>

Maximum IR Surface Temperature at 10% and 20% Duty Cycle  
Package base fixed at 85°C

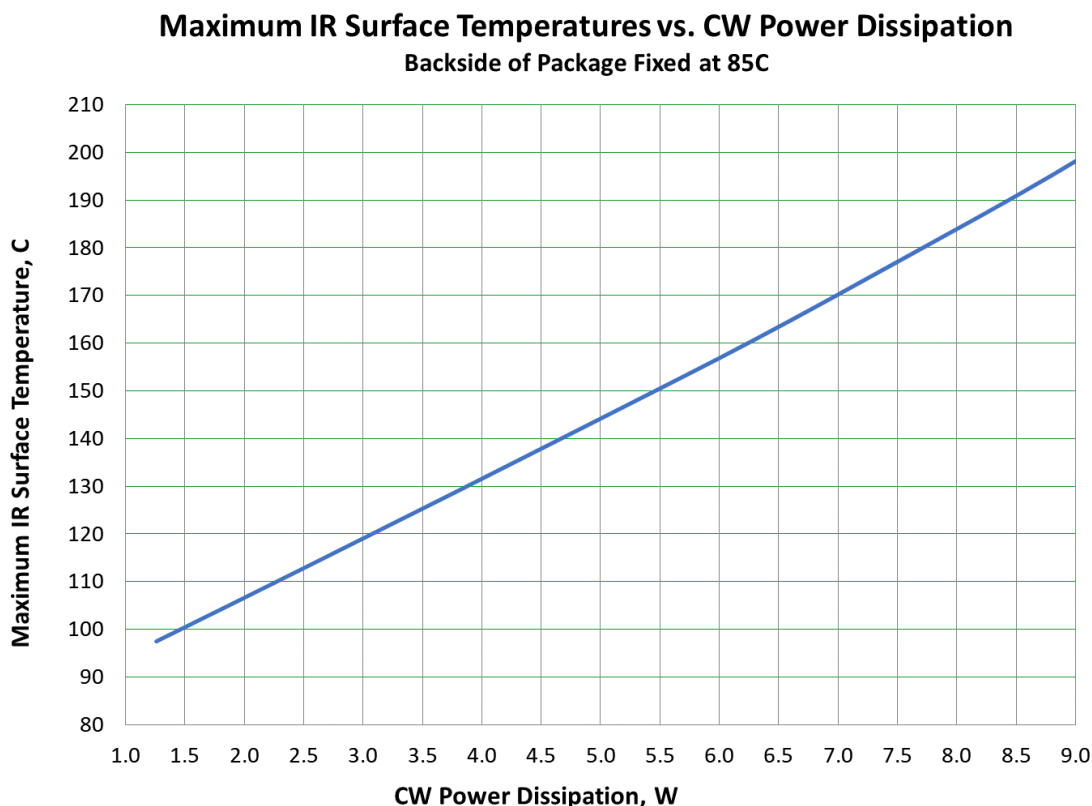


Parameter	Conditions	Values	Units
Thermal Resistance, Maximum IR Surface Temperature at Dissipated Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 185^{\circ}C$ , $P_{DISS} = 10.1\text{ W}$ , 100 $\mu$ S PW, 20% DC	9.9	$^{\circ}C/W$
Thermal Resistance, Maximum IR Surface Temperature at Dissipated Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 172^{\circ}C$ , $P_{DISS} = 8.8\text{ W}$ , 100 $\mu$ S PW, 20% DC	9.9	$^{\circ}C/W$
Thermal Resistance, Maximum IR Surface Temperature at Dissipated Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 158^{\circ}C$ , $P_{DISS} = 7.6\text{ W}$ , 100 $\mu$ S PW, 20% DC	9.6	$^{\circ}C/W$
Thermal Resistance, Maximum IR Surface Temperature at Dissipated Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 145^{\circ}C$ , $P_{DISS} = 6.3\text{ W}$ , 100 $\mu$ S PW, 20% DC	9.5	$^{\circ}C/W$
Thermal Resistance, Maximum IR Surface Temperature at Dissipated Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 133^{\circ}C$ , $P_{DISS} = 5.0\text{ W}$ , 100 $\mu$ S PW, 20% DC	9.6	$^{\circ}C/W$

Notes:

- Thermal resistance is measured to package backside.
- Refer to the following document: [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#)

### Thermal and Reliability Information – CW<sup>1</sup>



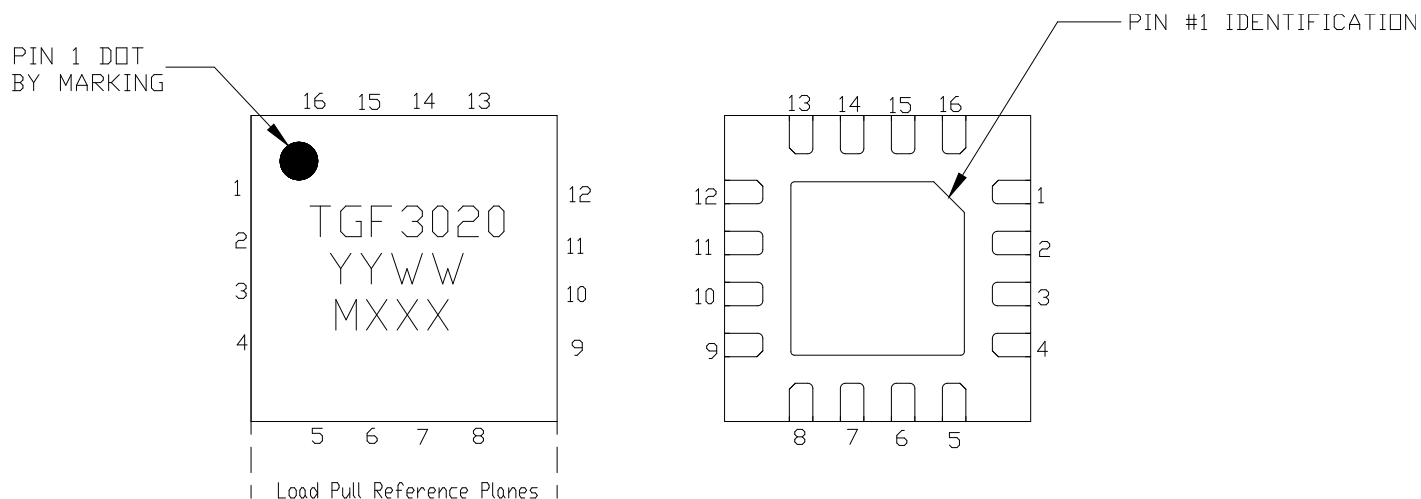
Parameter	Conditions	Values	Units
Thermal Resistance, Maximum IR Surface Temperature at Average Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 113^{\circ}C$ , $P_{DISS} = 2.52\text{ W}$	11.1	$^{\circ}C/W$
Thermal Resistance, Maximum IR Surface Temperature at Average Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 129^{\circ}C$ , $P_{DISS} = 3.78\text{ W}$	11.6	$^{\circ}C/W$
Thermal Resistance, Maximum IR Surface Temperature at Average Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 145^{\circ}C$ , $P_{DISS} = 5.04\text{ W}$	11.9	$^{\circ}C/W$
Thermal Resistance, Maximum IR Surface Temperature at Average Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 161^{\circ}C$ , $P_{DISS} = 6.30\text{ W}$	12.1	$^{\circ}C/W$
Thermal Resistance, Maximum IR Surface Temperature at Average Power ( $\theta_{JC}$ )	$T_{CASE} = +85^{\circ}C$ , $T_{CH} = 178^{\circ}C$ , $P_{DISS} = 7.56\text{ W}$	12.3	$^{\circ}C/W$

Notes:

- Thermal resistance is measured to package backside.
- Refer to the following document: [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#)

### Pin Configuration and Description<sup>1</sup>

Note 1: The TGF3020-SM will be marked with the “TGF3020” designator and a lot code marked below the part designator. The “YY” represents the last two digits of the calendar year the part was manufactured, the “WW” is the work week of the assembly lot start, the MXXX” is the production lot number.



Pin	Symbol	Description
2, 3	RF IN / $V_G$	Gate
10, 11	RF OUT / $V_D$	Drain
1, 4, 5, 6, 7, 8, 9, 12, 13, 14, 15, 16	NC	No Connection <sup>1</sup>
	Source	Source / Ground / Backside of part

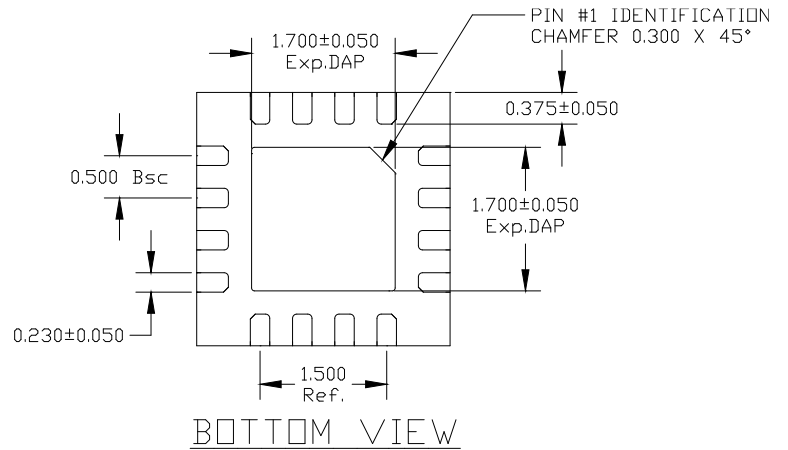
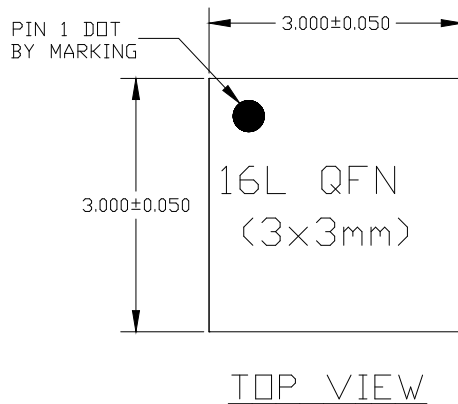
Note 1: Grounding pin 6 will cause performance degradation.

### Mechanical Drawing<sup>1</sup>

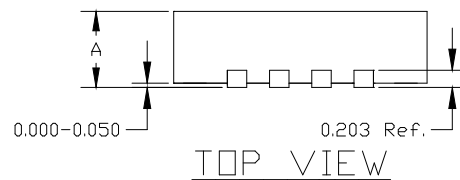
**Note 1:**

Unless otherwise noted, all dimension tolerances are  $\pm 0.127$  mm.

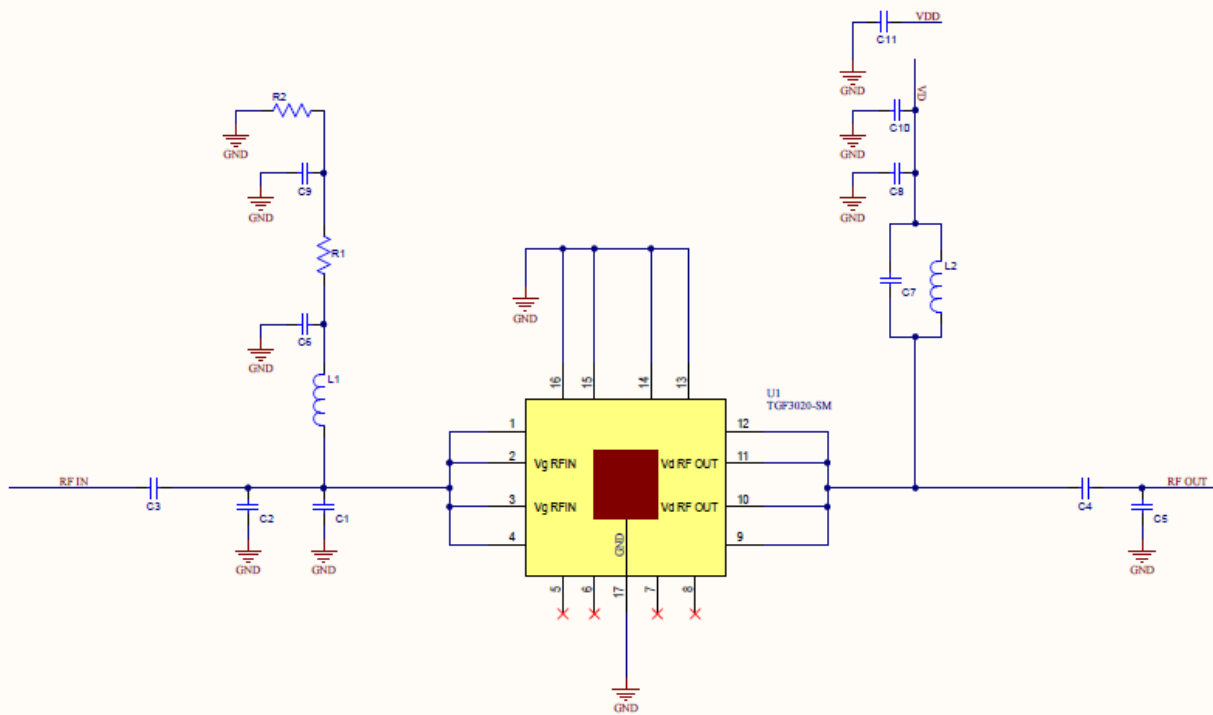
This package is lead-free/RoHS-compliant. The plating material on the leads is NiAu. It is compatible with both lead-free (maximum 260 °C reflow temperature) and tin-lead (maximum 245°C reflow temperature) soldering processes.



A	SLP	
	MAX.	0.900
	NOM.	0.850
	MIN.	0.800



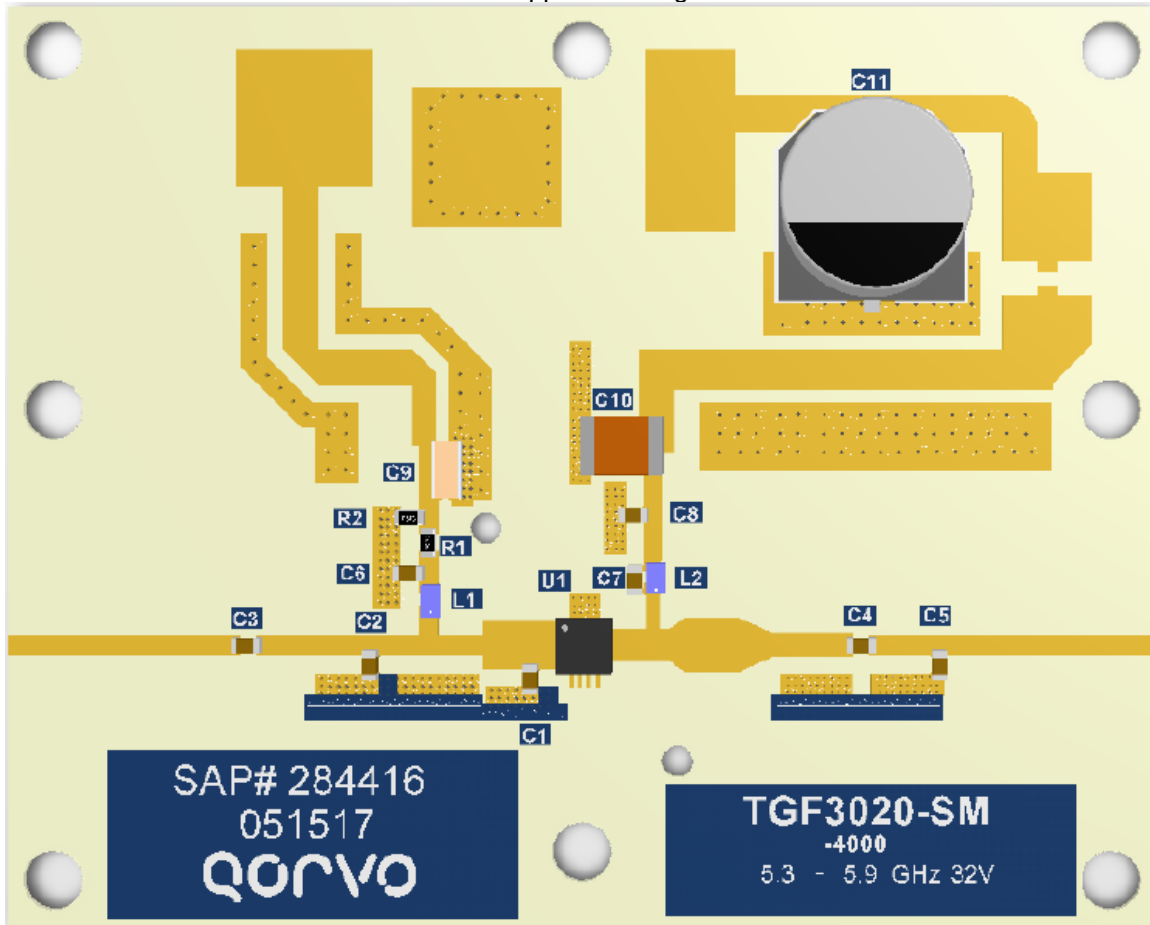
### 5.3 – 5.9 GHz Application Circuit - Schematic



Bias-up Procedure	Bias-down Procedure
1. Set $V_G$ to -3.5 V.	1. Turn off RF signal.
2. Set $I_D$ current limit to 30 mA.	2. Turn off $V_D$
3. Apply 32 V $V_D$ .	3. Wait 2 seconds to allow drain capacitor to discharge.
4. Slowly adjust $V_G$ until $I_D$ is set to 25 mA.	4. Turn off $V_G$
5. Set $I_D$ current limit to 0.3 A (Pulsed operation.)	
6. Apply RF.	

### 5.3 – 5.9 GHz Application Circuit - Layout

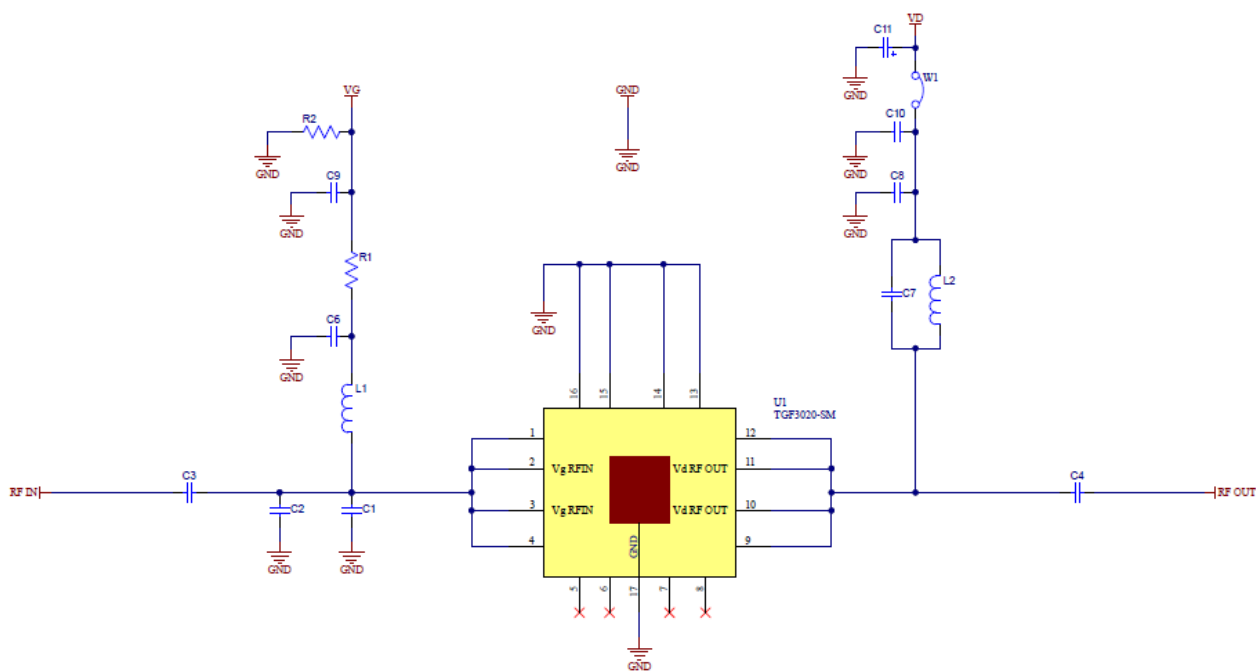
Board material is RO4350B 0.020" thickness with 1oz copper cladding. Overall EVB size is 2" x 2.5".



### 5.3 – 5.9 GHz Application Circuit - Bill of Materials

Reference Design	Value	Qty	Manufacturer	Part Number
R1	10 $\Omega$	1	Vishay	CRCW060310R0JNTA
R2	1 k $\Omega$	1	Vishay	CRCW06031K00JNTA
C1, C5	0.2 pF	2	Kyocera AVX	600S0R2AT250XT
C2	0.3 pF	1	Passive Plus	0603N0R3AW251X
C3, C4	5.1 pF	2	Kyocera AVX	600S5R1BT250X
C6, C7, C8	3.3 pF	3	Kyocera AVX	600S3R3BT250XT
C11	220 $\mu$ F	1	United Chemicon	EMVY500ADA221MJA0G
C9	10 $\mu$ F	1	Murata	LLL31MR60J106ME01L
C10	1 $\mu$ F	1	Kyocera AVX	18121C105KAT2A
L1	3.9nH	1	CoilCraft	0603CS-3N9XJRW
L2	2.2nH	1	CoilCraft	0603CS-2N2XJEW

### 4 – 6 GHz Application Circuit - Schematic



#### Bias-up Procedure

2. Set  $V_G$  to -4 V.
4. Set  $I_D$  current limit to 30 mA.
5. Apply 32 V  $V_D$ .
6. Slowly adjust  $V_G$  until  $I_D$  is set to 25 mA.
8. Set  $I_D$  current limit to 0.3 A (Pulsed operation.)
9. Apply RF.

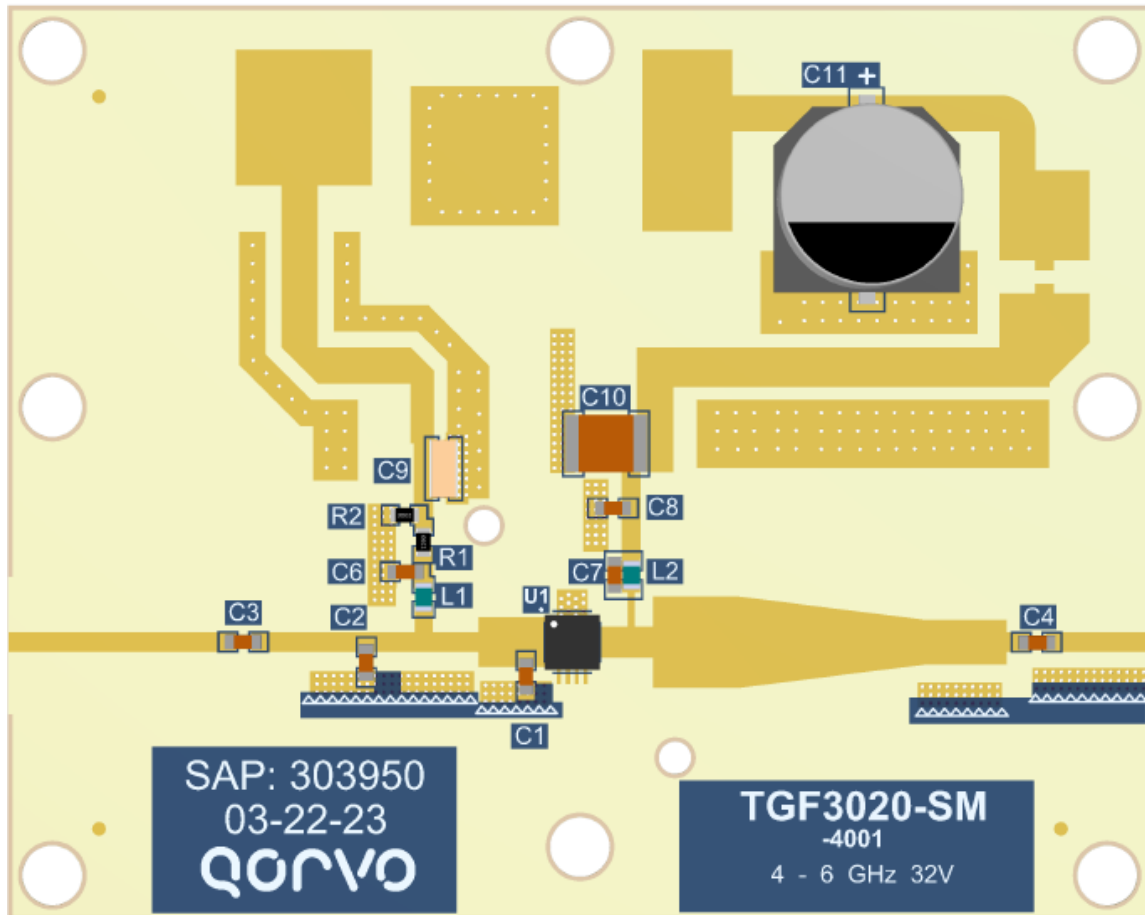
#### Bias-down Procedure

3. Turn off RF signal.
4. Turn off  $V_D$
5. Wait 2 seconds to allow drain capacitor to discharge.
7. Turn off  $V_G$



### 4 – 6 GHz Application Circuit - Layout

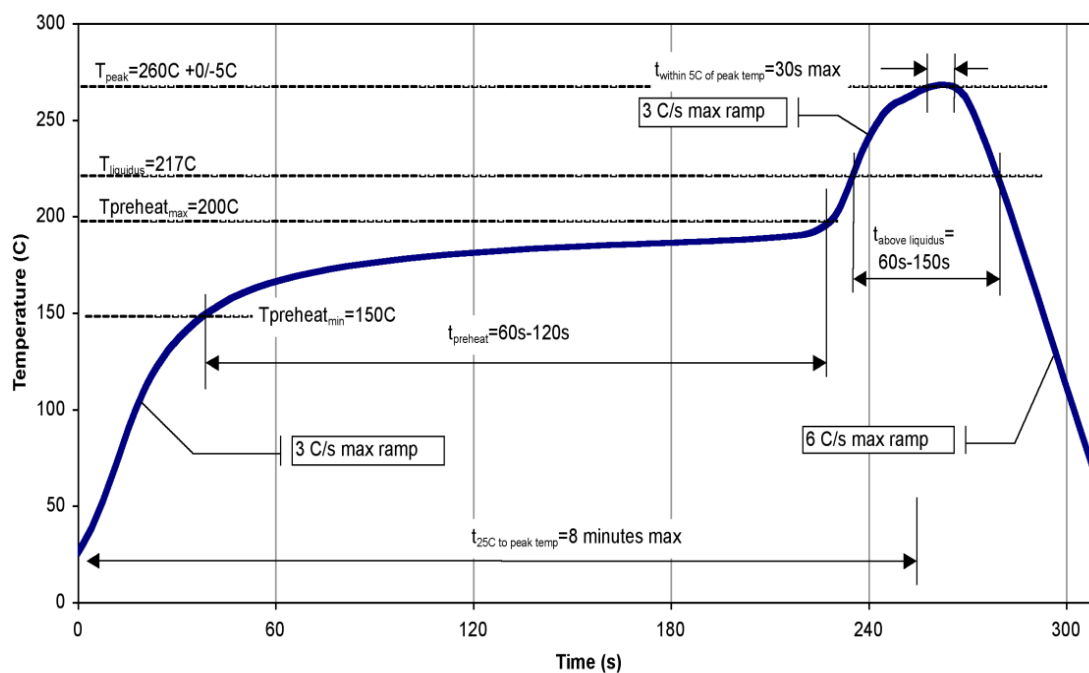
Board material is RO4350B 0.020" thickness with 1oz copper cladding. Overall EVB size is 2" x 2.5".



### 4 – 6 GHz Application Circuit - Bill of Materials

Reference Design	Value	Qty	Manufacturer	Part Number
R1	10 $\Omega$	1	Vishay	CRCW060310R0JNTA
R2	1 k $\Omega$	1	Vishay	CRCW06031K00JNTA
C1	0.2 pF	1	Kyocera AVX	600S0R2AT250XT
C2	0.3 pF	1	Passive Plus	0603N0R3AW251X
C3	5.1 pF	1	Kyocera AVX	600S5R1BT250X
C4	10 pF	1	Kyocera AVX	600S100JT250XT
C6, C7, C8	3.3 pF	3	Kyocera AVX	600S3R3BT250XT
C11	220 uF	1	United Chemicon	EMVY500ADA221MJA0G
C9	10 uF	1	TDK	C1632X5R0J106M130AC
C10	1 uF	1	Kyocera AVX	18121C105KAT2A
L1	3.9nH	1	CoilCraft	0603CS-3N9XJRW
L2	1.8nH	1	CoilCraft	0603CS-1N8XJRW

### Recommended Solder Temperature Profile



### Handling Precautions

Parameter	Rating	Standard
ESD – Human Body Model (HBM)	Class 1A (250V)	ESDA / JEDEC JS-001-2012
ESD – Charged Device Model (CDM)	Class C3 (1000V)	JEDEC JESD22-C101F
MSL – Moisture Sensitivity Level	Level 3	IPC/JEDEC J-STD-020



Caution!  
ESD-Sensitive Device

### Solderability

Compatible with both lead-free (260°C max. reflow temp.) and tin/lead (245°C max. reflow temp.) soldering processes. Solder profiles available upon request.

Contact plating: NiPdAu

### RoHS Compliance

This part is compliant with 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment) as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C<sub>15</sub>H<sub>12</sub>Br<sub>4</sub>O<sub>2</sub>) Free
- PFOS Free
- SVHC Free



### Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations:

Web: [www.qorvo.com](http://www.qorvo.com)

Tel: 1-844-890-8163

Email: [customer.support@qorvo.com](mailto:customer.support@qorvo.com)

### Important Notice

The information contained herein is believed to be reliable; however, Qorvo makes no warranties regarding the information contained herein and assumes no responsibility or liability whatsoever for the use of the information contained herein. All information contained herein is subject to change without notice. Customers should obtain and verify the latest relevant information before placing orders for Qorvo products. The information contained herein or any use of such information does not grant, explicitly or implicitly, to any party any patent rights, licenses, or any other intellectual property rights, whether with regard to such information itself or anything described by such information. **THIS INFORMATION DOES NOT CONSTITUTE A WARRANTY WITH RESPECT TO THE PRODUCTS DESCRIBED HEREIN, AND QORVO HEREBY DISCLAIMS ANY AND ALL WARRANTIES WITH RESPECT TO SUCH PRODUCTS WHETHER EXPRESS OR IMPLIED BY LAW, COURSE OF DEALING, COURSE OF PERFORMANCE, USAGE OF TRADE OR OTHERWISE, INCLUDING THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE.**

Without limiting the generality of the foregoing, Qorvo products are not warranted or authorized for use as critical components in medical, life-saving, or life-sustaining applications, or other applications where a failure would reasonably be expected to cause severe personal injury or death.

Copyright 2024 © Qorvo, Inc. | Qorvo is a registered trademark of Qorvo, Inc.